Se	arch	Notes	

Application/Control	No.

Applicant(s)/Patent	unde
Reexamination	

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Examiner

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SEARCHED			
Class	Subclass	Date	Examiner
257	77, 79 86, 489	9/5/2005	π
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INTERFERENCE SEARCHED			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST	9/5/2005	π
Interference Search History Printout	9/5/2005	π